

| | | | | |
|-----------------------------------|--|---------------------------------------|--|-------------|
| Notice of References Cited | | Application/Control No. 10/649,472 | Applicant(s)/Patent Under Reexamination CHENG ET AL | |
| | | Examiner Kin-Chan Chen | Art Unit 1765 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------|----------------|
| | A | US-6,610,577 | 08-2003 | Thomas et al. | 438/311 |
| | B | US-6,435,942 | 08-2002 | Jin et al. | 451/8 |
| | C | US-5,721,172 | 02-1998 | Jang et al. | 438/424 |
| | D | US-5,362,669 | 11-1994 | Boyd et al. | 438/437 |
| | E | US-6,664,190 | 12-2003 | Chen et al. | 438/697 |
| | F | US-6,017,803 | 01-2000 | Wong, Harianto | 438/430 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.